

# IGBT - Power, Co-PAK N-Channel, Field Stop VII (FS7), Non-SCR, TO247-3L 1200 V, 1.7 V, 60 A FGY60T120SWD

## Description

Using the novel field stop 7th generation IGBT technology and the Gen7 Diode in TO247 3-lead package, FGY60T120SWD offers the optimum performance with low switching and conduction losses for high-efficiency operations in various applications like Solar, UPS, and ESS.

#### **Features**

- Maximum Junction Temperature  $T_I = 175^{\circ}C$
- Positive Temperature Coefficient for Easy Parallel Operation
- High Current Capability
- Smooth and Optimized Switching
- Low Switching Loss
- RoHS Compliant

# **Applications**

- Boost and Inverter in Solar System
- UPS
- Energy Storage System

#### MAXIMUM RATINGS (T, I = 25°C unless otherwise noted)

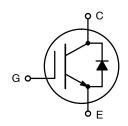
| Parameter   |  | Symbol                            | Value          | Unit |
|---|--|-----------------------------------|----------------|------|
| Collector-to-Emitter Voltage                        |  | V <sub>CES</sub>                  | 1200           | V    |
| Gate-to-Emitter Voltage                             |  | V <sub>GES</sub>                  | ±20            | V    |
| Transient Gate-to-Emitter V                         | oltage   |                                   | ±30            | V    |
| Collector Current                                   | T <sub>C</sub> = 25°C<br>(Note 1)                            | I <sub>C</sub>                    | 105            | Α    |
|   | T <sub>C</sub> = 100°C                                       |                                   | 60             |      |
| Power Dissipation                                   | T <sub>C</sub> = 25°C  | P <sub>D</sub>                    | 635            | W    |
|   | T <sub>C</sub> = 100°C                                       |                                   | 317            |      |
| Pulsed Collector Current                            | $T_C = 25^{\circ}C,$<br>$t_P = 10 \mu s$<br>(Note 2)         | I <sub>CM</sub>                   | 240            | Α    |
| Diode Forward Current                               | T <sub>C</sub> = 25°C  | I <sub>F</sub>                    | 120            | Α    |
|   | T <sub>C</sub> = 100°C                                       |                                   | 600            |      |
| Pulsed Diode Maximum<br>Forward Current             | T <sub>C</sub> = 25°C,<br>t <sub>P</sub> = 10 μs<br>(Note 2) | I <sub>FM</sub>                   | 240            | A    |
| Operating Junction and Storage<br>Temperature Range |  | T <sub>J</sub> , T <sub>STG</sub> | -55 to<br>+175 | °C   |
| Lead Temperature for Soldering Purposes             |  | TL                                | 260            | °C   |

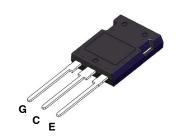
Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

- 1. Value limit by bond wire
- 2. Repetitive rating: Pulse width limited by max. Junction temperature

| BV <sub>CES</sub> | V <sub>CE(SAT)</sub> | I <sub>C</sub> |
|-------------------|----------------------|----------------|
| 1200 V            | 1.7 V                | 60 A           |

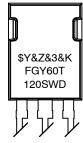
#### **PIN CONNECTIONS**





TO247-3LD CASE 340CD

#### **MARKING DIAGRAM**



\$Y = onsemi Logo &Z = Assembly Plant Code &3 = 3-Digit Date Code &K = 2-Digit Lot Traceability Code

FGY60T120SWD = Specific Device Code

#### ORDERING INFORMATION

| Device       | Package                 | Shipping           |
|--------------|-------------------------|--------------------|
| FGY60T120SWD | TO-247-3LD<br>(Pb-Free) | 30 Units /<br>Tube |

# THERMAL CHARACTERISTICS

| Parameter                                      | Symbol          | Value | Unit |
|--|-----------------|-------|------|
| Thermal Resistance, Junction-to-Case for IGBT  | $R_{	heta JC}$  | 0.24  | °C/W |
| Thermal Resistance, Junction-to-Case for Diode |                 | 0.41  |      |
| Thermal Resistance, Junction-to-Ambient        | $R_{\theta JA}$ | 40    |      |

# **ELECTRICAL CHARACTERISTICS OF IGBT** (T<sub>J</sub> = 25°C unless otherwise noted)

| Parameter   | Symbol                                  | Test Condition  | Min  | Тур   | Max  | Unit |
|---|---|---|------|-------|------|------|
| OFF CHARACTERISTICS   |   |   |      |       |      | •    |
| Collector-to-Emitter Breakdown Voltage                            | BV <sub>CES</sub>                       | $V_{GE} = 0 \text{ V}, I_{C} = 5 \text{ mA}$  | 1200 |       |      | V    |
| Collector-to-Emitter Breakdown Voltage<br>Temperature Coefficient | ΔBV <sub>CES</sub> /<br>ΔΤ <sub>J</sub> |   |      | 1.5   |      | V/°C |
| Zero Gate Voltage Collector Current                               | I <sub>CES</sub>                        | V <sub>GE</sub> = 0 V, V <sub>CE</sub> = V <sub>CES</sub>   |      |       | 40   | μΑ   |
| Gate-to-Emitter Leakage Current                                   | I <sub>GES</sub>                        | V <sub>GE</sub> = 20 V, V <sub>CE</sub> = 0 V   |      |       | ±400 | nA   |
| ON CHARACTERISTICS  |   |   |      |       |      |      |
| Gate Threshold Voltage  | V <sub>GE(TH)</sub>                     | $V_{GE} = V_{CE}$ , $I_C = 60 \text{ mA}$   | 5.6  | 6.55  | 7.4  | V    |
| Collector-to-Emitter Saturation Voltage                           | V <sub>CE(SAT)</sub>                    | $V_{GE} = 15 \text{ V}, I_{C} = 60 \text{ A}, T_{J} = 25^{\circ}\text{C}$   | 1.35 | 1.68  | 2.0  |      |
|   |   | V <sub>GE</sub> = 15 V, I <sub>C</sub> = 60 A, T <sub>J</sub> = 175°C   |      | 2.25  |      |      |
| DYNAMIC CHARACTERISTICS   |   |   |      |       |      |      |
| Input Capacitance   | C <sub>IES</sub>                        | V <sub>GE</sub> = 0 V, V <sub>CE</sub> = 30 V, f = 1 MHz  |      | 5093  |      | pF   |
| Output Capacitance  | C <sub>OES</sub>                        |   |      | 193   |      |      |
| Reverse Transfer Capacitance                                      | C <sub>RES</sub>                        |   |      | 25.2  |      |      |
| Total Gate Charge   | $Q_{G}$                                 | V <sub>CE</sub> = 600 V, V <sub>GE</sub> = 15 V, I <sub>C</sub> = 60 A  |      | 174   |      | nC   |
| Gate-to-Emitter Charge  | Q <sub>GE</sub>                         |   |      | 43.4  |      |      |
| Gate-to-Collector Charge  | Q <sub>GC</sub>                         |   |      | 65.1  |      |      |
| SWITCHING CHARACTERISTICS   |   |   |      |       |      |      |
| Turn-On Delay Time  | t <sub>d(on)</sub>                      | $V_{CE} = 600 \text{ V}, V_{GE} = 0/15 \text{ V}, I_{C} = 30 \text{ A}, R_{G} = 4.7 \Omega, T_{J} = 25^{\circ}\text{C}$ |      | 30.4  |      | ns   |
| Turn-Off Delay Time   | t <sub>d(off)</sub>                     | $H_G = 4.7 \Omega$ , $I_J = 25^{\circ}C$  |      | 146.4 |      |      |
| Rise Time   | t <sub>r</sub>                          |   |      | 15.2  |      |      |
| Fall Time   | t <sub>f</sub>                          |   |      | 68    |      |      |
| Turn-On Switching Loss  | E <sub>on</sub>                         |   |      | 1.6   |      | mJ   |
| Turn-Off Switching Loss   | E <sub>off</sub>                        |   |      | 0.9   |      |      |
| Total Switching Loss  | E <sub>ts</sub>                         |   |      | 2.6   |      |      |
| Turn-On Delay Time  | t <sub>d(on)</sub>                      | V <sub>CE</sub> = 600 V, V <sub>GE</sub> = 0/15 V,  |      | 31.2  |      | ns   |
| Turn-Off Delay Time   | t <sub>d(off)</sub>                     | $I_C = 60 \text{ A}, R_G = 4.7 \Omega, T_J = 25^{\circ}\text{C}$  |      | 130   |      |      |
| Rise Time   | t <sub>r</sub>                          | ]   |      | 40.8  |      |      |
| Fall Time   | t <sub>f</sub>                          | ]   |      | 68.8  |      |      |
| Turn-On Switching Loss  | E <sub>on</sub>                         |   |      | 4     |      | mJ   |
| Turn-Off Switching Loss   | E <sub>off</sub>                        |   |      | 1.9   |      |      |
|   | E <sub>ts</sub>                         | 1   |      | 5.8   |      |      |

# **ELECTRICAL CHARACTERISTICS OF IGBT** ( $T_J = 25^{\circ}C$ unless otherwise noted)

| Parameter                     | Symbol              | Test Condition   | Min  | Тур   | Max  | Unit |
|-------------------------------|---------------------|--|------|-------|------|------|
| Turn-On Delay Time            | t <sub>d(on)</sub>  | $V_{GE} = 0/15 \text{ V}, I_{C} = 30 \text{ A}, V_{CE} = 600 \text{ V},$ $R_{G} = 4.7 \Omega, T_{J} = 175^{\circ}\text{C}$ |      | 27.2  |      | ns   |
| Turn-Off Delay Time           | t <sub>d(off)</sub> |  |      | 168   |      |      |
| Rise Time                     | t <sub>r</sub>      |  |      | 16    |      |      |
| Fall Time                     | t <sub>f</sub>      |  |      | 102.4 |      |      |
| Turn-On Switching Loss        | E <sub>on</sub>     |  |      | 2.6   |      | mJ   |
| Turn-Off Switching Loss       | E <sub>off</sub>    |  |      | 1.2   |      | -    |
| Total Switching Loss          | E <sub>ts</sub>     |  |      | 3.8   |      |      |
| Turn-On Delay Time            | t <sub>d(on)</sub>  | $V_{GE} = 0/15 \text{ V}, I_{C} = 60 \text{ A},$   |      | 28.8  |      | ns   |
| Turn-Off Delay Time           | t <sub>d(off)</sub> | $V_{CE} = 600 \text{ V}, R_G = 4.7 \Omega, T_J = 175 ^{\circ}\text{C}$   |      | 153.6 |      |      |
| Rise Time                     | t <sub>r</sub>      |  |      | 38.4  |      |      |
| Fall Time                     | t <sub>f</sub>      |  |      | 120   |      | 1    |
| Turn-On Switching Loss        | E <sub>on</sub>     |  |      | 5.7   |      | mJ   |
| Turn-Off Switching Loss       | E <sub>off</sub>    |  |      | 2.8   |      |      |
| Total Switching Loss          | E <sub>ts</sub>     |  |      | 8.5   |      |      |
| DIODE CHARACTERISTICS         |                     |  |      |       |      |      |
| Forward Voltage               | V <sub>F</sub>      | I <sub>F</sub> = 60 A, T <sub>J</sub> = 25°C   | 1.62 | 1.91  | 2.22 | V    |
|                               |                     | I <sub>F</sub> = 60 A, T <sub>J</sub> = 175°C  |      | 2     |      |      |
| DIODE SWITCHING CHARACTERIST  | IC, INDUCTIVE L     | OAD  |      |       |      |      |
| Reverse Recovery Time         | t <sub>rr</sub>     | $V_R = 600 \text{ V}, I_F = 30 \text{ A},$<br>$dI_F/dt = 1000 \text{ A/}\mu\text{s}, T_J = 25^{\circ}\text{C}$             |      | 143   |      | ns   |
| Reverse Recovery Charge       | Q <sub>rr</sub>     |  |      | 2262  |      | nC   |
| Reverse Recovery Energy       | E <sub>rec</sub>    |  |      | 0.7   |      | mJ   |
| Peak Reverse Recovery Current | I <sub>RRM</sub>    |  |      | 32    |      | Α    |
| Reverse Recovery Time         | t <sub>rr</sub>     | $V_R = 600 \text{ V, } I_F = 60 \text{ A,}$<br>$dI_F/dt = 1000 \text{ A/}\mu\text{s, } T_J = 25^{\circ}\text{C}$           |      | 200   |      | ns   |
| Reverse Recovery Charge       | Q <sub>rr</sub>     |  |      | 3486  |      | nC   |
| Reverse Recovery Energy       | E <sub>rec</sub>    |  |      | 1.1   |      | mJ   |
| Peak Reverse Recovery Current | I <sub>RRM</sub>    |  |      | 35    |      | Α    |
| Reverse Recovery Time         | t <sub>rr</sub>     | V <sub>R</sub> = 600 V, I <sub>F</sub> = 30 A,<br>dI <sub>F</sub> /dt = 1000 A/μs, T <sub>J</sub> = 175°C                  |      | 221   |      | ns   |
| Reverse Recovery Charge       | Q <sub>rr</sub>     |  |      | 4908  |      | nC   |
| Reverse Recovery Energy       | E <sub>rec</sub>    |  |      | 1.7   |      | mJ   |
| Peak Reverse Recovery Current | I <sub>RRM</sub>    |  |      | 44    |      | Α    |
| Reverse Recovery Time         | t <sub>rr</sub>     | V <sub>R</sub> = 600 V, I <sub>F</sub> = 60 A,   |      | 334   |      | ns   |
| Reverse Recovery Charge       | Q <sub>rr</sub>     | dl <sub>F</sub> /dt = 1000 A/μs, T <sub>J</sub> = 175°C  |      | 8665  |      | nC   |
| Reverse Recovery Energy       | E <sub>rec</sub>    |  |      | 3.1   |      | mJ   |
| Peak Reverse Recovery Current | I <sub>RRM</sub>    |  |      | 52    |      | Α    |
|                               |                     | <b>.</b>   |      |       |      |      |

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

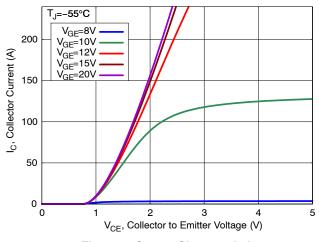


Figure 1. Output Characteristics

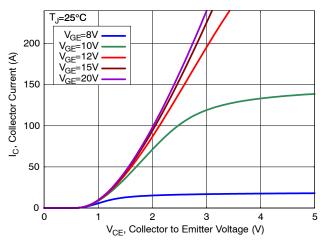


Figure 2. Output Characteristics

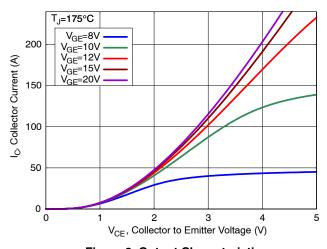


Figure 3. Output Characteristics

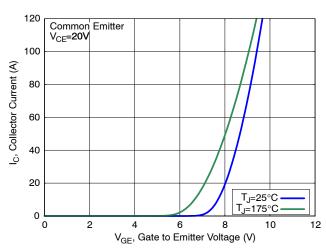


Figure 4. Transfer Characteristics

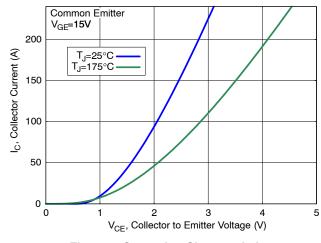


Figure 5. Saturation Characteristics

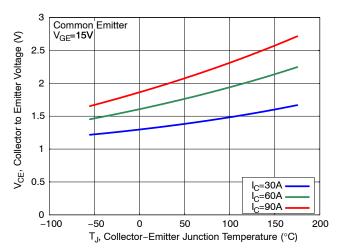


Figure 6. Saturation Voltage vs. Junction Temperature

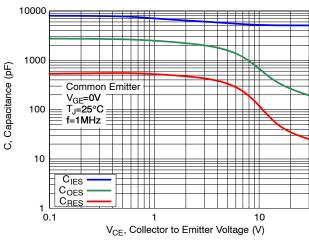


Figure 7. Capacitance Characteristics

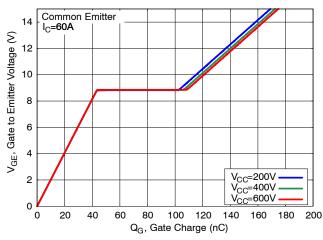


Figure 8. Gate Charge Characteristics

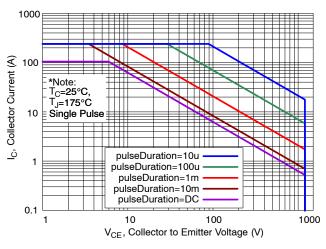


Figure 9. SOA Characteristics

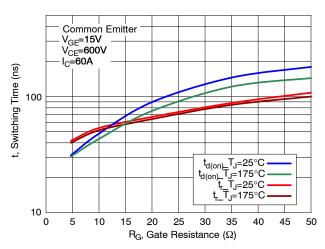


Figure 10. Turn-On Switching Time vs. Gate Resistance

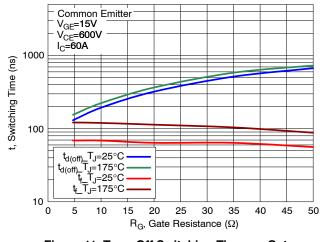


Figure 11. Turn-Off Switching Time vs. Gate Resistance

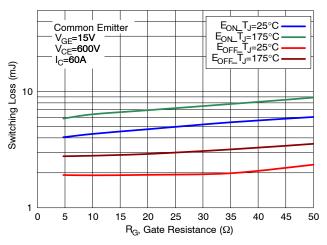
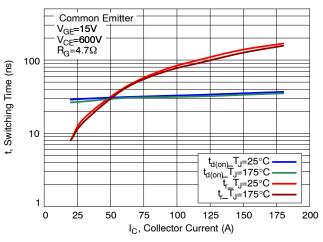


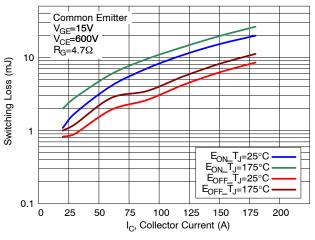
Figure 12. Switching Loss vs. Gate Resistance



1000 Common Emitter
V<sub>GE</sub>=15V
V<sub>CE</sub>=600V  $R_{G}=4.7\Omega$ t, Switching Time (ns) 100  $\begin{array}{c} t_{d(off)} T_{J} = 25^{\circ} C \\ t_{d(off)} T_{J} = 175^{\circ} C \\ t_{L} T_{J} = 25^{\circ} C \\ t_{L} T_{J} = 175^{\circ} C \end{array}$ 10 25 0 50 75 100 125 150 175 200 I<sub>C</sub>, Collector Current (A)

Figure 13. Turn-On Switching Time vs. Collector Current

Figure 14. Turn-Off Switching Time vs. Collector Current



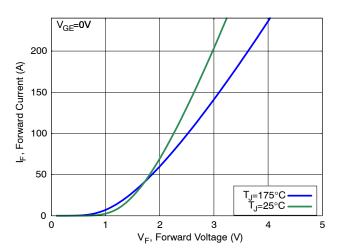
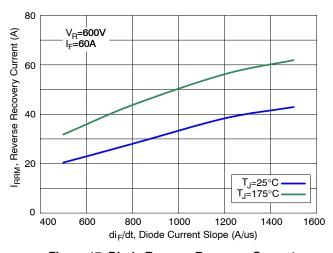


Figure 15. Switching Loss vs. Collector Current

Figure 16. Diode Forward Characteristics



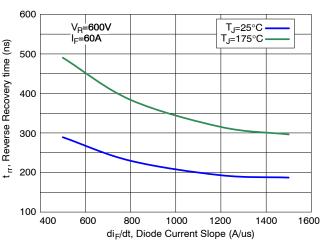


Figure 17. Diode Reverse Recovery Current

Figure 18. Diode Reverse Recovery Time

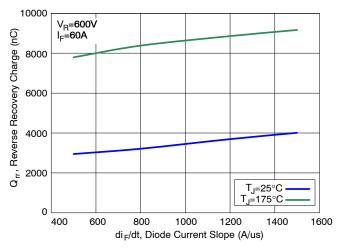


Figure 19. Diode Stored Charge Characteristics

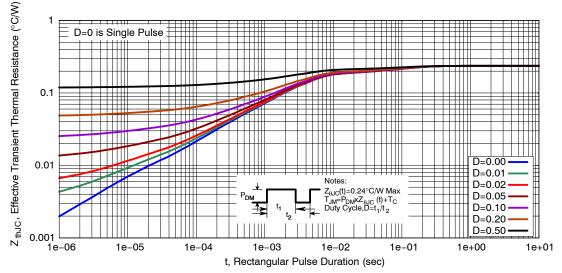


Figure 20. Transient Thermal Impedance of IGBT

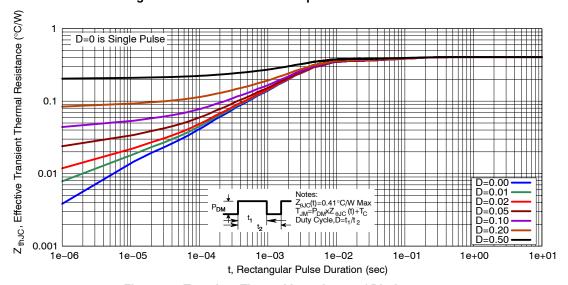


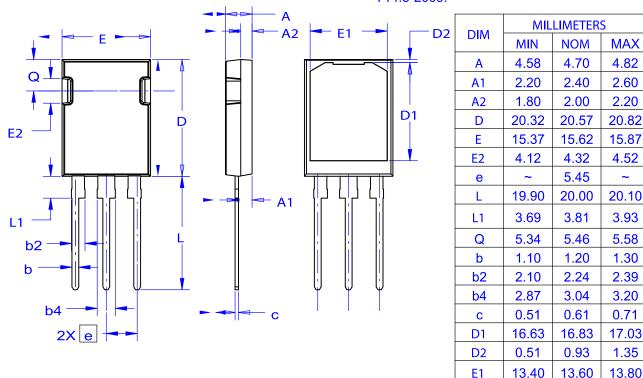
Figure 21. Transient Thermal Impedance of Diode

#### PACKAGE DIMENSIONS

TO-247-3LD CASE 340CD **ISSUE A** 

#### NOTES:

- A. THIS PACKAGE DOES NOT CONFORM TO ANY STANDARDS.
- B. ALL DIMENSIONS ARE IN MILLIMETERS. C. DIMENSIONS ARE EXCLUSIVE OF BURRS MOLD FLASH AND TIE BAR PROTRUSIONS.
- D. DIMENSION AND TOLERANCE AS PER ASME Y14.5-2009.



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